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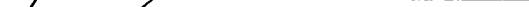
TRADEMAKES FORM PTO-1449 (REV 7-80)		Atty. Docket No. 3055-002-01	Application No. 09/774,266
INFORMATION DISCLOSURE STATEMENT		APPLICANT: Lotfi HEDHLI et al.	
		Filing Date: January 30, 2001	Group Art Unit: 1745

U.S. PATENT DOCUMENTS

FOREIGN PATENT DOCUMENTS

OTHER DOCUMENTS (Including Author, Title, Date, Pertinent Pages, Etc.)

Partial Search Report for European Application No. 01916103

EXAMINER	DATE CONSIDÉRÉE
	5/31/03

*EXAMINER: Initial if reference considered, whether or not citation is in conformance with MPEP 609; Draw line through citation if not in conformance and not considered. Include copy of this form with next communication to applicant.

FORM PTO-1449 (REV 7-80)

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U.S. PATENT DOCUMENTS

EXAMINER'S INITIALS & TRADEMARK	DOCUMENT NUMBER	DATE	NAME	CLASS	SUB-CLASS	FILING DATE, IF APPROPRIATE
ul	3,051,677	8/28/62	Rexford			
	3,178,399	4/13/65	Lo			
	3,475,396	10/28/69	McCain, et al.			
	3,857,827	12/31/74	Dohany			
	4,295,952	10/20/81	De Nora et al.			
	5,093,427	3/3/92	Barber			
	5,272,186	12/21/93	Jones			
	5,679,482	10/21/97	Ehrenberg et al.			
	5,795,668	8/18/98	Banerjee			
	5,880,204	3/9/99	McCarthy			
ul	5,962,140	10/5/99	Rajagopalan			

FOREIGN PATENT DOCUMENTS

	DOCUMENT NUMBER	DATE	COUNTRY	CLASS	SUB-CLASS	TRANSLATION YES <input checked="" type="checkbox"/> NO <input type="checkbox"/>
ul	✓ WO 97/41168	11/6/97	WIPO			
	✓ WO 98/20573	5/14/98	WIPO			
ul	✓ WO 98/22989	5/28/98	WIPO			

OTHER DOCUMENTS (Including Author, Title, Date, Pertinent Pages, Etc.)

✓	Mikael Paronen, et al., "Effects of Irradiation on Sulfonation of Poly(vinyl fluoride) J. Mater. Chem., 1997, 7(12), 2401-2406
✓	International Search Report from PCT/US-01/04995-dated 5/9/2001.

EXAMINER

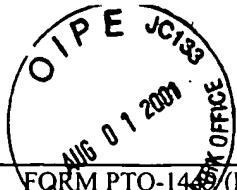
DATE CONSIDERED

1/03

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